MOSFET – SiC Power, Single N-Channel, TO247-4L 1200 V, 160 mΩ, 17.3 A

NTH4L160N120SC1

Features

- Typ. $R_{DS(on)} = 160 \text{ m}\Omega$
- Ultra Low Gate Charge $(Q_{G(tot)} = 34 \text{ nC})$
- High Speed Switching with Low Capacitance ($C_{oss} = 49.5 \text{ pF}$)
- 100% Avalanche Tested
- $T_I = 175^{\circ}C$
- This Device is Pb-Free and is RoHS Compliant

Typical Applications

- UPS
- DC/DC Converter
- Boost Inverter

MAXIMUM RATINGS (T_J = 25°C unless otherwise noted)

Parameter			Symbol	Value	Unit
Drain-to-Source Voltage			V_{DSS}	1200	V
Gate-to-Source Voltage			V_{GS}	-15/+25	V
Recommended Operation Values of Gate-to-Source Voltage		V_{GSop}	-5/+20	V	
Continuous Drain Current (Note 2)	Steady T _C = 25°C State		I _D	17.3	Α
Power Dissipation (Note 2)			P _D	111	W
Continuous Drain Current (Notes 1, 2)	Steady State	T _C = 100°C	I _D	12.3	Α
Power Dissipation (Notes 1, 2)			P _D	55.5	W
Pulsed Drain Current (Note 3)	T _A = 25°C		I _{DM}	69	Α
Operating Junction and Storage Temperature Range		T _J , T _{stg}	-55 to +175	°C	
Source Current (Body Diode)			I _S	11	Α
Single Pulse Drain-to-Source Avalanche Energy (I _{L(pk)} = 16 A, L = 5 mH) (Note 4)			E _{AS}	128	mJ
Maximum Lead Temperature for Soldering (1/8" from case for 5 s)			TL	300	°C

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

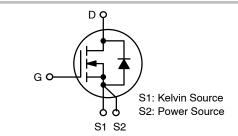
- JA is constant value to follow guide table of LV/HV discrete final datasheet generation.
- The entire application environment impacts the thermal resistance values shown, they are not constants and are only valid for the particular conditions noted.
- 3. Repetitive rating, limited by max junction temperature.
- 4. EAS of 128 mJ is based on starting $T_J = 25^{\circ}\dot{C}$; L = 5 mH, $I_{AS} = 16$ A, $V_{DD} = 120$ V, $V_{GS} = 18$ V.



ON Semiconductor®

www.onsemi.com

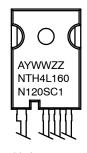
V _{(BR)DSS}	R _{DS(ON)} MAX	I _D MAX
1200 V	224 mΩ @ 20 V	17.3 A



N-CHANNEL MOSFET



MARKING DIAGRAM



A = Assembly Location

Y = Year WW = Work Week ZZ = Lot Traceability

NTH4L160N120SC1 = Specific Device Code

ORDERING INFORMATION

Device	Package	Shipping
NTH4L160N120SC1	TO247-4L	30 ea / Tube

THERMAL RESISTANCE MAXIMUM RATINGS

Parameter	Symbol	Max	Unit
Junction-to-Case - Steady State (Note 2)	$R_{ heta JC}$	1.35	°C/W
Junction-to-Ambient - Steady State (Notes 1, 2)	$R_{\theta JA}$	40	

ELECTRICAL CHARACTERISTICS ($T_J = 25^{\circ}C$ unless otherwise specified)

Parameter	Symbol	Test Condition		Min	Тур	Max	Unit
OFF CHARACTERISTICS	•				1		
Drain-to-Source Breakdown Voltage	V _{(BR)DSS}	V _{GS} = 0 V, I _D = 1 mA		1200	-	_	V
Drain-to-Source Breakdown Voltage Temperature Coefficient	V _{(BR)DSS} /T _J	I _D = 1 mA, referenced to 25°C		-	0.6	-	V/°C
Zero Gate Voltage Drain Current	I _{DSS}	V _{GS} = 0 V,	T _J = 25°C	-	_	100	μΑ
		V _{DS} = 1200 V	T _J = 175°C	-	_	1	mA
Gate-to-Source Leakage Current	I _{GSS}	$V_{GS} = +25/-15 \text{ V}, V_{D}$	S = 0 V	-	_	±1	μΑ
ON CHARACTERISTICS (Note 3)							
Gate Threshold Voltage	V _{GS(TH)}	$V_{GS} = V_{DS}, I_D = 2.5 \text{ n}$	nΑ	1.8	3.1	4.3	V
Recommended Gate Voltage	V_{GOP}			-5	-	+20	V
Drain-to-Source On Resistance	R _{DS(on)}	V _{GS} = 20 V, I _D = 12 A	, T _J = 25°C	-	160	224	mΩ
		V _{GS} = 20 V, I _D = 12 A	, T _J = 175°C	-	271	377	
Forward Transconductance	9 _{FS}	$V_{DS} = 20 \text{ V}, I_D = 12 \text{ A}$		-	3.2	-	S
CHARGES, CAPACITANCES & GATE RES	SISTANCE						
Input Capacitance	C _{ISS}	V _{GS} = 0 V, f = 1 MHz, V _{DS} = 800 V		-	665	-	pF
Output Capacitance	C _{OSS}			-	49.5	-	
Reverse Transfer Capacitance	C _{RSS}			-	4.3	-	
Total Gate Charge	Q _{G(TOT)}	V _{GS} = -5/20 V, V _{DS} = 600 V, I _D = 16 A		-	34	-	nC
Threshold Gate Charge	Q _{G(TH)}			-	6	-	
Gate-to-Source Charge	Q _{GS}			-	12.5	-	
Gate-to-Drain Charge	Q_{GD}			-	9.6	-	
Gate-Resistance	R_{G}	f = 1 MHz		-	1.4	_	Ω
SWITCHING CHARACTERISTICS, VGS =	10 V				•	•	
Turn-On Delay Time	t _{d(ON)}	$V_{GS} = -5/20 \text{ V},$ $V_{DS} = 800 \text{ V},$ $I_{D} = 16 \text{ A},$ $R_{G} = 6 \Omega$ inductive load		-	11	20	ns
Rise Time	t _r			-	10	20	
Turn-Off Delay Time	t _{d(OFF)}			-	14	25	
Fall Time	t _f			-	7	14	
Turn-On Switching Loss	E _{ON}			-	104	-	μJ
Turn-Off Switching Loss	E _{OFF}			-	32	-	
Total Switching Loss	E _{tot}			-	136	-	
DRAIN-SOURCE DIODE CHARACTERIST	ics						
Continuous Drain-Source Diode Forward Current	I _{SD}	V _{GS} = -5 V, T _J = 25°C		-	-	11	Α
Pulsed Drain-Source Diode Forward Current (Note 3)	I _{SDM}			-	-	69	
Forward Diode Voltage	V_{SD}	V _{GS} = -5 V, I _{SD} = 6 A, T _J = 25°C		-	4	_	V
Reverse Recovery Time	t _{RR}	V _{GS} = -5/20 V, I _{SD} = 16 A, dI _S /dt = 1000 A/μs		-	15	_	ns
Reverse Recovery Charge	Q _{RR}			-	47	_	nC

ELECTRICAL CHARACTERISTICS ($T_J = 25^{\circ}C$ unless otherwise specified) (continued)

Parameter	Symbol	Test Condition	Min	Тур	Max	Unit
DRAIN-SOURCE DIODE CHARACTERISTICS						
Reverse Recovery Energy	E _{REC}	$V_{GS} = -5/20 \text{ V}, I_{SD} = 16 \text{ A},$	_	3.9	_	μJ
Peak Reverse Recovery Current	I _{RRM}	$dI_S/dt = 1000 A/\mu s$	-	6.6	-	Α
Charge time	Ta]	-	7.0	-	ns
Discharge time	Tb		-	7.4	-	ns

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

TYPICAL CHARACTERISTICS

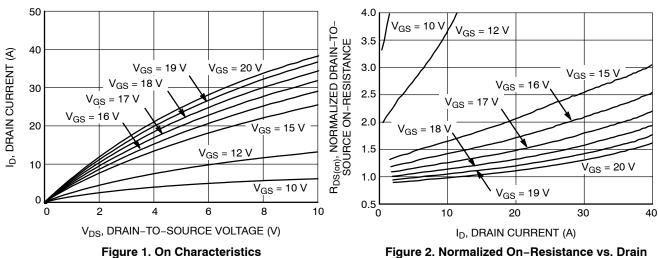


Figure 1. On Characteristics

Current and Gate Voltage 700 I_D = 12 A $I_D = 12 A$ $V_{GS} = 20 \text{ V}$ R_{DS(on)}, ON-RESISTANCE (mΩ) 600 500 400 $T_J = 150^{\circ}C$ 300 200

125 150 175

100

0

100

10 11

 $V_{GS} = -5 V$

Figure 3. On-Resistance Variation with **Temperature**

T_J, JUNCTION TEMPERATURE (°C)

50

25

75 100

0.7

-75 -50

-25

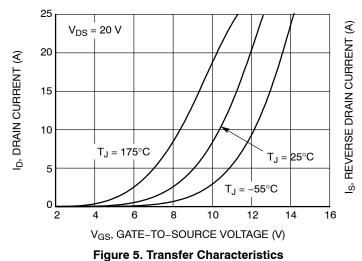
0

Figure 4. On-Resistance vs. Gate-to-Source Voltage

V_{GS}, GATE-TO-SOURCE VOLTAGE (V)

13 14 15 16 17

 $T_{,l} = 25^{\circ}C$



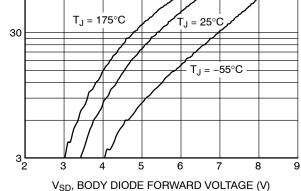


Figure 6. Diode Forward Voltage vs. Current

TYPICAL CHARACTERISTICS

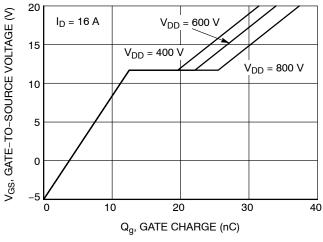


Figure 7. Gate-to-Source Voltage vs. Total Charge

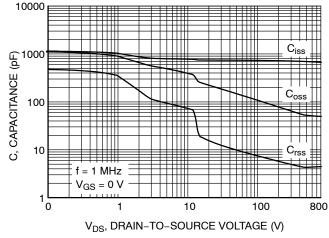


Figure 8. Capacitance vs. Drain-to-Source Voltage

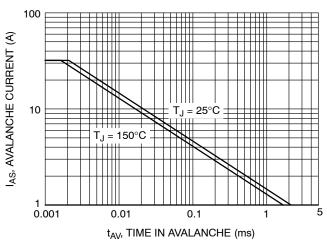


Figure 9. Unclamped Inductive Switching Capability

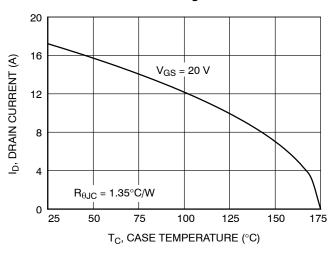


Figure 10. Maximum Continuous Drain Current vs. Case Temperature

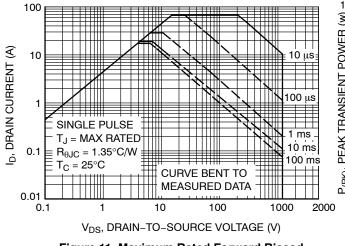


Figure 11. Maximum Rated Forward Biased Safe Operating Area

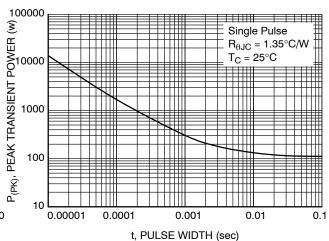


Figure 12. Single Pulse Maximum Power Dissipation

TYPICAL CHARACTERISTICS

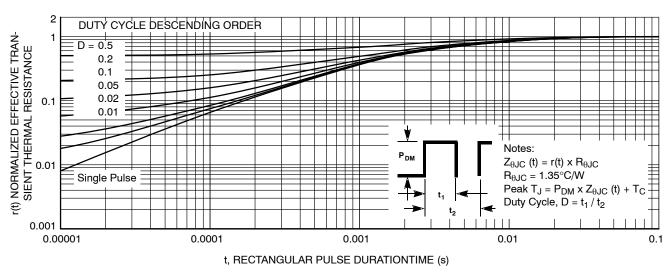
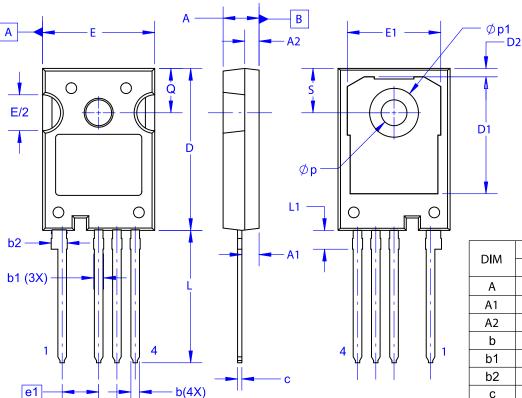


Figure 13. Junction-to-Case Transient Thermal Response Curve

TO-247-4LD CASE 340CJ **ISSUE A**

DATE 16 SEP 2019



NOTES:

e 2X-0.254 M

- A. NO INDUSTRY STANDARD APPLIES TO THIS PACKAGE.
 B. DIMENSIONS ARE EXCLUSIVE OF BURRS, MOLD
 FLASH, AND TIE BAR EXTRUSIONS.
 C. ALL DIMENSIONS ARE IN MILLIMETERS.
 D. DRAWING CONFORMS TO ASME Y14.5-2009.

DIM	MIN	NOM	MAX		
Α	4.80	5.00	5.20		
A1	2.10	2.40	2.70		
A2	1.80	2.00	2.20		
b	1.07	1.20	1.33		
b1	1.20	1.40	1.60		
b2	2.02	2.22	2.42		
С	0.50	0.60	0.70		
D	22.34	22.54	22.74		
D1	16.00	16.25	16.50		
D2	0.97	1.17	1.37		
е	2.54 BSC				
e1	5.08 BSC				
E	15.40	15.60	15.80		
E1	12.80	13.00	13.20		
E/2	4.80	5.00	5.20		
L	18.22	18.42	18.62		
L1	2.42	2.62	2.82		
р	3.40	3.60	3.80		
p1	6.60	6.80	7.00		
Q	5.97	6.17	6.37		
S	5.97	6.17	6.37		

MILLIMETERS

DOCUMENT NUMBER:	98AON13852G	Electronic versions are uncontrolled except when accessed directly from the Document Repository Printed versions are uncontrolled except when stamped "CONTROLLED COPY" in red.		
DESCRIPTION:	TO-247-4LD		PAGE 1 OF 1	

ON Semiconductor and (III) are trademarks of Semiconductor Components Industries, LLC dba ON Semiconductor or its subsidiaries in the United States and/or other countries. ON Semiconductor reserves the right to make changes without further notice to any products herein. ON Semiconductor makes no warranty, representation or guarantee regarding the suitability of its products for any particular purpose, nor does ON Semiconductor assume any liability arising out of the application or use of any product or circuit, and specifically disclaims any and all liability, including without limitation special, consequential or incidental damages. ON Semiconductor does not convey any license under its patent rights nor the rights of others.

onsemi, ONSEMI, and other names, marks, and brands are registered and/or common law trademarks of Semiconductor Components Industries, LLC dba "onsemi" or its affiliates and/or subsidiaries in the United States and/or other countries. onsemi owns the rights to a number of patents, trademarks, copyrights, trade secrets, and other intellectual property. A listing of onsemi's product/patent coverage may be accessed at www.onsemi.com/site/pdf/Patent-Marking.pdf. Onsemi reserves the right to make changes at any time to any products or information herein, without notice. The information herein is provided "as-is" and onsemi makes no warranty, representation or guarantee regarding the accuracy of the information, product features, availability, functionality, or suitability of its products for any particular purpose, nor does onsemi assume any liability arising out of the application or use of any product or circuit, and specifically disclaims any and all liability, including without limitation special, consequential or incidental damages. Buyer is responsible for its products and applications using onsemi products, including compliance with all laws, regulations and safety requirements or standards, regardless of any support or applications provided by onsemi. "Typical" parameters which may be provided in onsemi data sheets and/or specifications can and do vary in different applications and actual performance may vary over time. All operating parameters, including "Typicals" must be validated for each customer application by customer's technical experts. onsemi does not convey any license under any of its intellectual property rights nor the rights of others. onsemi products are not designed, intended, or authorized for use as a critical component in life support systems or any EDA class 3 medical devices or medical devices with a same or similar classification in a foreign jurisdiction or any devices intended for implantation in the human body. Should Buyer pu

PUBLICATION ORDERING INFORMATION

LITERATURE FULFILLMENT:
Email Requests to: orderlit@onsemi.com

onsemi Website: www.onsemi.com

TECHNICAL SUPPORT North American Technical Support: Voice Mail: 1 800-282-9855 Toll Free USA/Canada Phone: 011 421 33 790 2910

Europe, Middle East and Africa Technical Support:

Phone: 00421 33 790 2910

For additional information, please contact your local Sales Representative

X-ON Electronics

Largest Supplier of Electrical and Electronic Components

Click to view similar products for MOSFET category:

Click to view products by ON Semiconductor manufacturer:

Other Similar products are found below:

614233C 648584F IRFD120 JANTX2N5237 FCA20N60_F109 FDZ595PZ 2SK2545(Q,T) 405094E 423220D TPCC8103,L1Q(CM MIC4420CM-TR VN1206L SBVS138LT1G 614234A 715780A NTNS3166NZT5G SSM6J414TU,LF(T 751625C BUK954R8-60E NTE6400 SQJ402EP-T1-GE3 2SK2614(TE16L1,Q) 2N7002KW-FAI DMN1017UCP3-7 EFC2J004NUZTDG ECH8691-TL-W FCAB21350L1 P85W28HP2F-7071 DMN1053UCP4-7 NTE221 NTE2384 NTE2903 NTE2941 NTE2945 NTE2946 NTE2960 NTE2967 NTE2969 NTE2976 NTE455 NTE6400A NTE2910 NTE2916 NTE2956 NTE2911 DMN2080UCB4-7 TK10A80W,S4X(S SSM6P69NU,LF DMP22D4UFO-7B DMN1006UCA6-7